Single-Channel, 5-V Controller **PWP PACKAGE** (TOP VIEW) **Synchronous-Rectifier Drivers for Greater** Than 90% Efficiency IOUT 🗆 28 □ PWRGD **Useable for All Common DSP Supply** NC I 2 27 ■ VP0 **Voltages – Popular Output Voltage Options** OCP I 3 26 TT VP1 25 **Set With Program Pins** VHYST I VREFB □□ 24 □ VP3 **EVM Available** VSENSE I 6 23 **Ideal for Applications With Current Ranges** 22 ANAGND From 3 A to 30 A. 21 SLOWST I 8 ☐ IOUTLO **Hysteretic Control Technique Enables Fast** 20 BIAS  $\square$  □ LOSENSE Transient Response — Ideal for 'C6000 or LODRV  $\Box$ 10 19 ☐ HISENSE Multiple 'C5000 Applications LOHIB  $\Box$ 11 18 ☐ BOOTLO DRVGND I 12 17 **Low Supply Current** LOWDR I □ BOOT 13 16 - 3 mA in Operation □ V<sub>CC</sub> DRV  $\square$ 14 15

NC - Not Connected

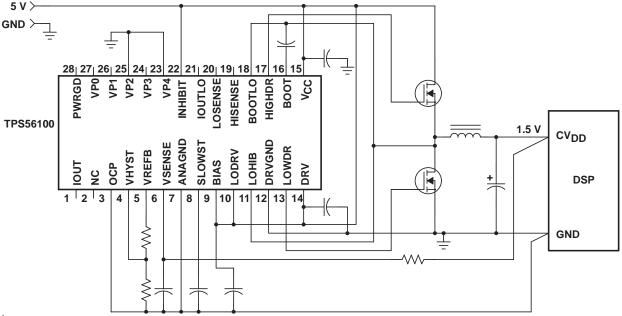
# - 90 μA in Standby

- **Power Good Output**
- 28-Pin TSSOP PowerPAD™ Package

# description

The TPS56100 is a high-efficiency synchronous-buck regulator controller which provides an accurate programmable supply voltage to low-voltage digital signal processors, such as the 'C6x and 'C54x DSPs. An internal 5-bit DAC is used to program the reference voltage from 1.3 V to 2.6 V. Higher output voltages can be implemented using an external input resistive divider. The TPS56100 uses a fast hysteretic control method that provides a quick transient response. The propagation delay from the comparator input to the output driver is

# application example





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# description (continued)

less than 300 ns, even at maximum output current. Overcurrent shutdown and crossover protection combine to eliminate destructive faults in the output MOSFETs, thereby protecting the processor during operation. The slowstart current source is proportional to the reference voltage, thereby eliminating variation of the slowstart timing when changes are made to the output voltage. When the output drops to less than 93% of the nominal output voltage, PWRGD will pull the open-drain output low. The overvoltage circuit will disable the output drivers if the output voltage rises more than 15% above the nominal output voltage. The TPS56100 also includes an inhibit input to control power sequencing and undervoltage lockout thereby insuring the 5-V supply is within limits before the controller starts. The 2-A MOSFET drivers can power multiple MOSFETs in parallel to drive single or multiple DSPs and load currents up to 30 A. The high-side driver can be configured as a ground-referenced driver or as a floating bootstrap driver with the included internal bootstrap Schottky diode.

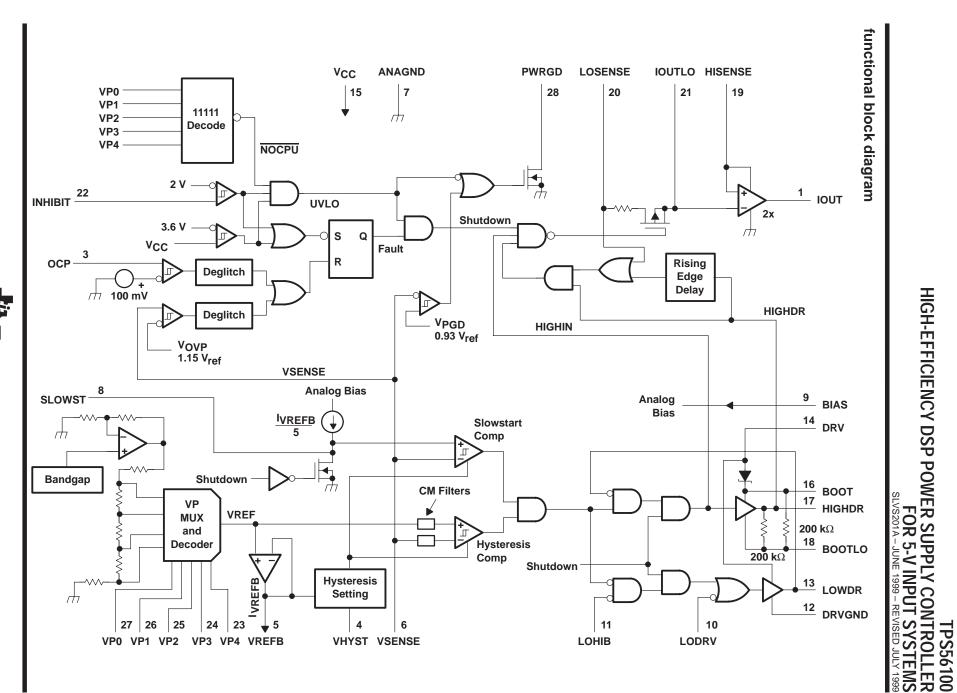
The TPS56100 is available in a 28-pin TSSOP PowerPAD package, which increases thermal efficiency and eliminates bulky heat sinks.

### **AVAILABLE OPTIONS**

|              | PACKAGES        |                 |  |  |
|--------------|-----------------|-----------------|--|--|
| TJ           | TSSOP†<br>(PWP) | EVM             |  |  |
| 0°C to 125°C | TPS561000PWP    | TPS56100EVM-128 |  |  |

<sup>†</sup> The PWP package is also available taped and reel. To order, add an R to the end of the part number (e.g., TPS561000PWPR).





# TPS56100 HIGH-EFFICIENCY DSP POWER SUPPLY CONTROLLER FOR 5-V INPUT SYSTEMS SLVS201A – JUNE 1999 – REVISED JULY 1999

# **Terminal Functions**

| TERMIN  | NAL | ,,_ | DECORPORATION                                                                                                                                                                                                                                                                                                                                        |
|---------|-----|-----|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| NAME    | NO. | 1/0 | DESCRIPTION                                                                                                                                                                                                                                                                                                                                          |
| ANAGND  | 7   | ı   | Analog ground                                                                                                                                                                                                                                                                                                                                        |
| BIAS    | 9   | I   | Analog BIAS pin. This terminal must be connected to 5-V supply voltage. A 1-μF ceramic capacitor should be connected from BIAS to ANAGND.                                                                                                                                                                                                            |
| BOOT    | 16  | ı   | Bootstrap. Connect a 1-μF low-ESR capacitor from BOOT to BOOTLO.                                                                                                                                                                                                                                                                                     |
| BOOTLO  | 18  | I   | Bootstrap low. Connect BOOTLO to the junction of the high-side and low-side FETs for floating drive configuration. Connect BOOTLO to PGND for ground reference drive configuration.                                                                                                                                                                  |
| DRV     | 14  | ı   | Drive bias for the FET drivers. This terminal must be connected to 5-V supply voltage. A 1-µF ceramic capacitor should be connected from DRV to DRVGND.                                                                                                                                                                                              |
| DRVGND  | 12  | I   | Drive ground. Ground for FET drivers. Connect to FET PWRGND.                                                                                                                                                                                                                                                                                         |
| HIGHDR  | 17  | 0   | High drive. Output drive to high-side power switching FETs                                                                                                                                                                                                                                                                                           |
| HISENSE | 19  | I   | High current sense. For current sensing across high-side FETs, connect to the drain of the high-side FETs; for optional resistor sensing scheme, connect to power supply side of current-sense resistor placed in series with high-side FET drain.                                                                                                   |
| INHIBIT | 22  | ı   | Disables the drive signals to the MOSFET drivers.                                                                                                                                                                                                                                                                                                    |
| IOUT    | 1   | 0   | Current out. Output voltage on this pin is proportional to the load current as measured across the Rds(on) of the high-side FETs. The voltage on this pin equals 2×Rds(on)×IOUT. In applications where very accurate current sensing is required, a sense resistor should be connected between the input supply and the drain of the high-side FETs. |
| IOUTLO  | 21  | 0   | Current sense low output. This is the voltage on the LOSENSE pin when the high-side FETs are on. A ceramic capacitor should be connected from IOUTLO to HISENSE to hold the sensed voltage while the high-side FETs are off. Capacitance range should be between 0.033 $\mu$ F and 0.1 $\mu$ F.                                                      |
| LODRV   | 10  | ı   | Low drive enable. Normally tied to 5 V. To activate the low-side FETs as a crowbar, pull LODRV low.                                                                                                                                                                                                                                                  |
| LOHIB   | 11  | I   | Low side inhibit. Connect to the junction of the high and low side FETs to control the anti-cross-conduction and eliminate shoot-through current. Disabled when configured in crowbar mode.                                                                                                                                                          |
| LOSENSE | 20  | I   | Low current sense. For current sensing across high-side FETs, connect to the source of the high-side FETs; for optional resistor sensing scheme, connect to high-side FET drain side of current-sense resistor placed in series with high-side FET drain.                                                                                            |
| LOWDR   | 13  | 0   | Low drive. Output drive to synchronous rectifier FETs                                                                                                                                                                                                                                                                                                |
| NC      | 2   |     | Not connected                                                                                                                                                                                                                                                                                                                                        |
| OCP     | 3   | ı   | Over current protection. Current limit trip point is set with a resistor divider between IOUT and ANAGND.                                                                                                                                                                                                                                            |
| PWRGD   | 28  | 0   | Power good. Power Good signal goes high when output voltage is within 7% of voltage set by VID pins. Open-drain output.                                                                                                                                                                                                                              |
| SLOWST  | 8   | 0   | Slow Start (soft start). A capacitor from SLOWST to ANAGND sets the slowstart time.  Slowstart current = IVREFB/5                                                                                                                                                                                                                                    |
| Vсс     | 15  | I   | 5-V supply. A 1-μF ceramic capacitor should be connected from V <sub>CC</sub> to DRVGND.                                                                                                                                                                                                                                                             |
| VHYST   | 4   | I   | HYSTERESIS set pin. The hysteresis is set with a resistor divider from $V_{REFB}$ to ANAGND. The hysteresis window = $2 \times (V_{REFB} - V_{HYST})$                                                                                                                                                                                                |
| VP0     | 27  | I   | Voltage programming input 0                                                                                                                                                                                                                                                                                                                          |
| VP1     | 26  | I   | Voltage programming input 1                                                                                                                                                                                                                                                                                                                          |
| VP2     | 25  | I   | Voltage programming input 2                                                                                                                                                                                                                                                                                                                          |
| VP3     | 24  | I   | Voltage programming input 3                                                                                                                                                                                                                                                                                                                          |
| VP4     | 23  | I   | Voltage programming input 4. Digital inputs that set the output voltage of the converter. The code pattern for setting the output voltage is located in Table 1. Internally pulled up to 5 V.                                                                                                                                                        |
| VREFB   | 5   | 0   | Buffered reference voltage from VP network                                                                                                                                                                                                                                                                                                           |
| VSENSE  | 6   | I   | Voltage sense Input. To be connected to converter output voltage bus to sense and control output voltage. It is recommended that an RC low pass filter be connected at this pin to filter noise.                                                                                                                                                     |



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# detailed description

# V<sub>REF</sub>

The reference/voltage programming (VP) section consists of a temperature-compensated bandgap reference and a 5-bit voltage selection network. The 5 VP terminals are inputs to the VP selection network and are TTL-compatible inputs internally pulled up to 5 V. The VP codes conform to the Intel  $VRM\,8.3\,DC$ -DC Converter Specification for voltage settings between 1.8 V and 2.6 V, and they are decremented by 50 mV, down to 1.3 V, for the lower VP settings. Voltages higher than  $V_{REF}$  can be implemented using an external resistive divider. Refer to Table 1 for the VP code settings. The output voltage of the VP network,  $V_{REF}$ , is within  $\pm 1.5\%$  of the nominal setting over the VP range of 1.3 V to 2.6 V, including a junction temperature range of 0°C to +125°C. The output of the reference/VP network is indirectly brought out through a buffer to the  $V_{REF}$  pin. The voltage on this pin will be within 2% of  $V_{REF}$ . It is not recommended to drive loads with  $V_{REF}$ , other than setting the hysteresis of the hysteretic comparator, because the current drawn from  $V_{REF}$  sets the charging current for the slowstart capacitor. Refer to the slowstart section for additional information.

# hysteretic comparator

The hysteretic comparator regulates the output voltage of the synchronous-buck converter. The hysteresis is set by 2 external resistors and is centered about  $V_{REF}$ . The 2 external resistors form a resistor divider from  $V_{REF}$  to ANAGND, with the output voltage connecting to the  $V_{HYST}$  pin. The hysteresis of the comparator will be equal to twice the voltage difference between the  $V_{REFB}$  and  $V_{HYST}$  pins. The propagation delay from the comparator inputs to the driver outputs is 300 ns (maximum). The maximum hysteresis setting is 60 mV.

# low-side driver

The low-side driver is designed to drive low-Rds(on) n-channel MOSFETs. The current rating of the driver is 2 A, source and sink. The bias to the low-side driver is derived from DRV.

# high-side driver

The high-side driver is designed to drive low-Rds(on) n-channel MOSFETs. The current rating of the driver is 2 A, source and sink. The high-side driver can be configured either as a ground-referenced driver or as a floating bootstrap driver. When configured as a floating driver, the bias voltage to the driver is developed from DRV. The internal bootstrap diode connected between the DRV and BOOT pins is a Schottky for improved drive efficiency. The maximum voltage that can be applied between BOOT and DRVGND is 30 V. The driver can be referenced to ground by connecting BOOTLO to DRVGND, and connecting BOOT to a voltage supply.

# deadtime control

Deadtime control prevents shoot-through current from flowing through the main power FETs during switching transitions by actively controlling the turnon times of the MOSFET drivers. The high-side driver is not allowed to turn on until the gate-drive voltage to the low-side FETs is below 2 V; the low-side driver is not allowed to turn on until the voltage at the junction of the high-side and low-side FETs (Vphase) is below 2 V.

## current sensing

Current sensing is achieved by sampling and holding the voltage across the high-side power FETs while the high-side FETs are on. The sampling network consists of an internal 85- $\Omega$  switch and an external ceramic hold capacitor. Recommended value of the hold capacitor is between 0.033  $\mu$ F and 0.1  $\mu$ F. Internal logic controls the turnon and turnoff of the sample/hold switch such that the switch does not turn on until the Vphase voltage transitions high, and the switch turns off when the input to the high-side driver goes low. The sampling will occur only when the high-side FETs are conducting current. The voltage on the IOUT pin equals 2 times the sensed high-side voltage. In applications where a higher accuracy in current sensing is required, a sense resistor can be placed in series with the high-side FETs, and the voltage across the sense resistor can be sampled by the current sensing circuit.



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# detailed description (continued)

### inhibit

INHIBIT is a TTL-compatible digital input used to enable the controller. When INHIBIT is low, the output drivers are low and the slowstart capacitor is discharged. When INHIBIT goes high, the short across the slowstart capacitor is released and normal converter operation begins. The 5-V supply must be above UVLO thresholds before the controller is allowed to start up. The inhibit start threshold is 2.1 V and the hysteresis is 100 mV for the INHIBIT comparator.

# V<sub>CC</sub> undervoltage lockout (UVLO)

The undervoltage lockout circuit disables the controller while the  $V_{CC}$  supply is below the 4-V start threshold during power up. When the controller is disabled, the output drivers will be low and the slowstart capacitor is discharged. When  $V_{CC}$  exceeds the start threshold, the short across the slowstart capacitor is released and normal converter operation begins. There is a 0.5-V hysteresis in the undervoltage lockout circuit for noise immunity.

### slowstart

The slowstart circuit controls the rate at which  $V_O$  powers up. A capacitor is connected between SLOWST and ANAGND and is charged by an internal current source. The current source is proportional to the reference voltage, so that the charging rate of  $C_{SLOWST}$  is proportional to the reference voltage. By making the charging current proportional to  $V_{REF}$ , the power-up time for  $V_O$  will be independent of  $V_{REF}$ . Thus,  $C_{SLOWST}$  can remain the same value for all VP settings. The slowstart charging current is determined by the following equation:

$$I_{slowstart} = I(V_{REFB}) / 5$$
 (amps)

Where I(V<sub>REFB</sub>) is the current flowing out of V<sub>REFB</sub>.

It is recommended that no additional loads be connected to  $V_{REFB}$ , other than the resistor divider for setting the hysteresis voltage. The maximum current that can be sourced by the  $V_{REFB}$  circuit is 500  $\,\mu$ A. The equation for setting the slowstart time is:

$$t_{SLOWST} = 5 \times C_{SLOWST} \times R_{VREFB}$$
 (seconds)

Where R<sub>VREFB</sub> is the total external resistance from V<sub>REFB</sub> to ANAGND.

# power good

The power-good circuit monitors for an undervoltage condition on  $V_O$ . If  $V_O$  is 7% below  $V_{REF}$ , then the PWRGD pin is pulled low. PWRGD is an open-drain output.

# overvoltage protection

The overvoltage protection (OVP) circuit monitors  $V_O$  for an overvoltage condition. If  $V_O$  is 15% above  $V_{REF}$ , then a fault latch is set and both output drivers are turned off. The latch will remain set until  $V_{CC}$  goes below the undervoltage lockout value or INHIBIT is low. A 3- $\mu$ s deglitch timer is included for noise immunity. Refer to the LODRV section for information on how to protect the microprocessor against overvoltages due to a shorted high-side power FET.



# detailed description (continued)

# overcurrent protection

The overcurrent protection (OCP) circuit monitors the current through the high-side FET. The overcurrent threshold is adjustable with an external resistor divider between IOUT and ANAGND, with the divider voltage connected to the OCP pin. If the voltage on OCP exceeds 100 mV, then a fault latch is set and the output drivers are turned off. The latch will remain set until  $V_{CC}$  goes below the undervoltage lockout value and back up above 3.6 V or INHIBIT is similarly brought below its stop threshold and back above its start threshold. A 3- $\mu$ s deglitch timer is included for noise immunity. The OCP circuit is also designed to protect the high-side power FET against a short-to-ground fault on the terminal common to both power FETs.

# **LODRV**

The LODRV circuit is designed to protect the microprocessor against overvoltages that can occur if the high-side power FETs become shorted. External components sensing an overvoltage condition are required to use this feature. When an overvoltage fault occurs, the low-side FETs are used as a crowbar. LODRV is pulled low and the low-side FET will be turned on, overriding all control signals inside the TPS5210 controller. The crowbar action will short the input supply to ground through the faulted high-side FETs and the low-side FETs. A fuse in series with  $V_{\rm in}$  should be added to disconnect the short circuit.

**Table 1. Voltage Programming Codes** 

|     | (0 = GND, 1 = | /P TERMINALS<br>= floating or pu | S<br>ull-up to 5 V) |     | V <sub>REF</sub> |
|-----|---------------|----------------------------------|---------------------|-----|------------------|
| VP4 | VP3           | VP2                              | VP1                 | VP0 | (Vdc)            |
| 0   | 1             | 1                                | 1                   | 1   | 1.30             |
| 0   | 1             | 1                                | 1                   | 0   | 1.35             |
| 0   | 1             | 1                                | 0                   | 1   | 1.40             |
| 0   | 1             | 1                                | 0                   | 0   | 1.45             |
| 0   | 1             | 0                                | 1                   | 1   | 1.50             |
| 0   | 1             | 0                                | 1                   | 0   | 1.55             |
| 0   | 1             | 0                                | 0                   | 1   | 1.60             |
| 0   | 1             | 0                                | 0                   | 0   | 1.65             |
| 0   | 0             | 1                                | 1                   | 1   | 1.70             |
| 0   | 0             | 1                                | 1                   | 0   | 1.75             |
| 0   | 0             | 1                                | 0                   | 0   | 1.80             |
| 0   | 0             | 1                                | 0                   |     | 0                |
| 0   | 0             | 0                                | 1                   | 1   | 1.90             |
| 0   | 0             | 0                                | 1                   | 0   | 1.95             |
| 0   | 0             | 0                                | 0                   | 1   | 2.00             |
| 0   | 0             | 0                                | 0                   | 0   | 2.05             |
| 1   | 1             | 1                                | 1                   | 1   | No CPU           |
| 1   | 1             | 1                                | 1                   | 0   | 2.10             |
| 1   | 1             | 1                                | 0                   | 1   | 2.20             |
| 1   | 1             | 1                                | 0                   | 0   | 2.30             |
| 1   | 1             | 0                                | 1                   | 1   | 2.40             |
| 1   | 1             | 0                                | 1                   | 0   | 2.50             |
| 1   | 1             | 0                                | 0                   | 1   | 2.60             |

**Table 1. Voltage Programming Codes (Continued)** 

|     | VP TERMINALS (0 = GND, 1 = floating or pull-up to 5 V) |     |     |     |       |  |
|-----|--------------------------------------------------------|-----|-----|-----|-------|--|
| VP4 | VP3                                                    | VP2 | VP1 | VP0 | (Vdc) |  |
| 1   | 1                                                      | 0   | 0   | 0   | 2.60  |  |
| 1   | 0                                                      | 1   | 1   | 1   | 2.60  |  |
| 1   | 0                                                      | 1   | 1   | 0   | 2.60  |  |
| 1   | 0                                                      | 1   | 0   | 1   | 2.60  |  |
| 1   | 0                                                      | 1   | 0   | 0   | 2.60  |  |
| 1   | 0                                                      | 0   | 1   | 1   | 2.60  |  |
| 1   | 0                                                      | 0   | 1   | 0   | 2.60  |  |
| 1   | 0                                                      | 0   | 0   | 1   | 2.60  |  |
| 1   | 0                                                      | 0   | 0   | 0   | 2.60  |  |

# absolute maximum ratings over operating virtual junction temperature (unless otherwise noted)†

| Supply voltage range, V <sub>CC</sub> (see Note1), BIAS, DRV           |                              |
|------------------------------------------------------------------------|------------------------------|
| Input voltage range: BOOT to DRVGND (High-side Driver ON)              | 0.3 V to 30 V                |
| BOOT to HIGHDRV                                                        | –0.3 V to 15 V               |
| BOOT to BOOTLO                                                         | –0.3 V to 15 V               |
| INHIBIT, VPx, LODRV                                                    | –0.3 V to 7.3 V              |
| PWRGD, OCP                                                             | 0.3 V to 7 V                 |
| LOHIB, LOSENSE, IOUTLO, HISENSE                                        | 0.3 V to 7 V                 |
| VSENSE                                                                 | –0.3 V to 5 V                |
| Voltage difference between ANAGND and DRVGND                           | ±0.5 V                       |
| Output current, V <sub>RFFB</sub>                                      | 0.5 mA                       |
| Continuous total power dissipation                                     | See Dissipation Rating Table |
| Operating virtual junction temperature range, T <sub>J</sub>           |                              |
| Storage temperature range, T <sub>stq</sub>                            |                              |
| Lead temperature soldering 1,6 mm (1/16 inch) from case for 10 seconds | 260°C                        |

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: Unless otherwise specified, all voltages are with respect to ANAGND.

# **DISSIPATION RATING TABLE**

| PACKAGE | $T_{\mbox{$\Delta$}} \leq 25^{\circ}\mbox{$C$}$ POWER RATING | DERATING FACTOR<br>ABOVE T <sub>A</sub> = 25°C | T <sub>A</sub> = 70°C<br>POWER RATING | T <sub>A</sub> = 85°C<br>POWER RATING |
|---------|--------------------------------------------------------------|------------------------------------------------|---------------------------------------|---------------------------------------|
| PWP     | 1150 mW                                                      | 11.5 mW/°C                                     | 630 mW                                | 460 mW                                |



# recommended operating conditions

|                                                           | MIN | MAX  | UNIT |
|-----------------------------------------------------------|-----|------|------|
| Supply voltage, V <sub>CC</sub>                           | 4.5 | 6    | V    |
| Input voltage, BOOT to DRVGND                             | 0   | 28   | V    |
| Input voltage, BOOT to BOOTLO                             | 0   | 13   | V    |
| Input voltage, INHIBIT, VPx, LODRV, PWRGD, OCP            | 0   | 6    | V    |
| Input voltage, LOHIB, LOSENSE, IOUTLO, HISENSE, BIAS, DRV | 0   | 6    | V    |
| Input voltage, VSENSE                                     | 0   | 4.5  | V    |
| Voltage difference between ANAGND and DRVGND              | 0   | ±0.2 | V    |
| Output current, V <sub>REFB</sub> †                       | 0   | 0.4  | mA   |

<sup>†</sup> Not recommended to load V<sub>RFFB</sub> other than to set hystersis since I<sub>VRFFB</sub> sets slowstart time.

# electrical characteristics over recommended operating virtual junction temperature range, $V_{CC} = 5 \text{ V}$ (unless otherwise noted)

# reference/voltage programming

|       | PARAMETER                             | TEST CONDITIONS                                                                 | MIN                     | TYP              | MAX                     | UNIT |
|-------|---------------------------------------|---------------------------------------------------------------------------------|-------------------------|------------------|-------------------------|------|
| VREF  | Cumulative voltage reference accuracy | $V_{CC}$ = 4.5 to 5.5 V, 1.3 V $\leq$ V <sub>REF</sub> $\leq$ 2.6 V, See Note 2 | -1.5%                   |                  | 1.5%                    |      |
| VPx   | High-level input voltage              |                                                                                 | 2.25                    |                  |                         | V    |
| VPx   | Low-level input voltage               |                                                                                 |                         |                  | 1                       | V    |
|       | Output voltage                        | IVREFB = 50 μA                                                                  | V <sub>REF</sub> -10 mV | V <sub>REF</sub> | V <sub>REF</sub> +10 mV | V    |
| VREFB | Output regulation                     | 10 μA ≤ I <sub>O</sub> ≤ 500 μA                                                 |                         | 2                |                         | mV   |
| VPx   | Input pullup resistance               |                                                                                 |                         | 190              | ·                       | kΩ   |

NOTES: 2. Cumulative reference accuracy is the combined accuracy of the reference voltage and the input offset voltage of the hysteretic comparator. Cumulative accuracy equals the average of the high-level and low-level thresholds of the hysteretic comparator.

3. This parameter is ensured by design and is not production tested.



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# electrical characteristics over recommended operating virtual junction temperature range, $V_{CC} = 5 \text{ V}$ (unless otherwise noted) (continued)

# power good

|                  | PARAMETER                   | TEST CONDITIONS          | MIN | TYP | MAX  | UNIT              |
|------------------|-----------------------------|--------------------------|-----|-----|------|-------------------|
|                  | Undervoltage trip threshold |                          | 90  | 93  | 95   | %V <sub>REF</sub> |
| VOL              | Low-level output voltage    | I <sub>O</sub> = 2.5 mA  |     | 0.4 | 0.75 | V                 |
| loh              | High-level input current    | V <sub>PWRGD</sub> = 5 V |     | 1   |      | μΑ                |
| V <sub>hys</sub> | Hysteresis voltage          |                          |     | 3   |      | %V <sub>REF</sub> |

# slowstart

| PARAMETER                       | TEST CONDITIONS                                                     |      | TYP | MAX  | UNIT |
|---------------------------------|---------------------------------------------------------------------|------|-----|------|------|
| Charge current                  | $V_{SLOWST}$ = 0.5 V, $V_{VREFB}$ = 1.3 V, $I_{VREFB}$ = 65 $\mu$ A | 10.4 | 13  | 15.6 | μА   |
| Discharge current               | V <sub>SLOWST</sub> = 1 V                                           | 3    |     |      | mA   |
| Comparator input offset voltage |                                                                     | -18  |     | 18   | mV   |
| Comparator input bias current   | See Note 3                                                          |      | 10  | 100  | nA   |
| Comparator hysteresis           |                                                                     | -8.5 |     | 8.5  | mV   |

NOTE 3: This parameter is ensured by design and is not production tested.

# hysteretic comparator

| PARAMETER                  | TEST CONDITIONS                                                              | MIN        | TYP | MAX | UNIT |
|----------------------------|------------------------------------------------------------------------------|------------|-----|-----|------|
| Input offset voltage       | See Note 3                                                                   | -4         |     | 4   | mV   |
| Input bias current         | See Note 3                                                                   |            |     | 500 | nA   |
| Hysteresis accuracy        | V <sub>REFB</sub> - V <sub>HYST</sub> = 15 mV<br>(Hysteresis window = 30 mV) | <b>-</b> 5 |     | 5   | mV   |
| Maximum hysteresis setting | VREFB - VHYST = 30 mV                                                        |            | 60  |     | mV   |

NOTE 3: This parameter is ensured by design and is not production tested.

# thermal shutdown

| PARAMETER                   | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|-----------------------------|-----------------|-----|-----|-----|------|
| Over temperature trip point | See Note 3      |     | 160 |     | °C   |
| Hysteresis                  | See Note 3      |     | 10  |     | °C   |

NOTE 3: This parameter is ensured by design and is not production tested.



# **TPS56100** HIGH-EFFICIENCY DSP POWER SUPPLY CONTROLLER FOR 5-V INPUT SYSTEMS SLVS201A – JUNE 1999 – REVISED JULY 1999

# electrical characteristics over recommended operating virtual junction temperature range, V<sub>CC</sub> = 5 V (unless otherwise noted) (continued)

# high-side VDS sensing

| PARAMETER            |                          | TEST CONDITIONS                                                                           | MIN | TYP | MAX  | UNIT |
|----------------------|--------------------------|-------------------------------------------------------------------------------------------|-----|-----|------|------|
|                      | Gain                     |                                                                                           |     | 2   |      | V/V  |
|                      | Initial accuracy         | VHISENSE = 5 V, VLOSENSE = 4.5 V                                                          | 194 |     | 206  | mV   |
| IOUTLO               | Sink current             | V <sub>IOUTLO</sub> = 5 V                                                                 |     |     | 250  | nA   |
| IOUT                 | Source current           | V <sub>IOUT</sub> = 0.5 V, V <sub>HISENSE</sub> = 5 V, V <sub>IOUTLO</sub> = 4.5 V        | 500 |     |      | μΑ   |
| IOUT                 | Sink current             | V <sub>IOUT</sub> = 0.05 V, V <sub>HISENSE</sub> = 5 V,<br>V <sub>IOUTLO</sub> = 5 V      |     |     |      | μΑ   |
| Output voltage swing |                          | VHISENSE = 4.5 V, $R_{IOUT}$ = 10 kΩ                                                      | 0   |     | 1    | V    |
|                      | Cutput voltage swing     | $V_{HISENSE} = 3 \text{ V, R}_{IOUT} = 10 \text{ k}\Omega$                                | 0   |     | 0.75 | V    |
| LOSENSE              | High-level input voltage | V                                                                                         |     |     |      | V    |
| LOSENSE              | Low-level input voltage  | VHISENSE = 4.5 V (see Note 3)                                                             |     |     | 2.4  | V    |
|                      |                          | 4.5 V ≤ VHISENSE ≤ 5.5 V,<br>LOSENSE connected to HISENSE,<br>VHISENSE - VIOUTLO = 0.15 V | 62  | 85  | 123  | Ω    |
|                      | Sample/hold resistance   | 3 V ≤ VHISENSE ≤ 3.6 V,<br>LOSENSE connected to HISENSE,<br>VHISENSE - VIOUTLO = 0.15 V   | 67  | 95  | 144  | 52   |
| CMRR                 |                          | VHISENSE = 5.5 V to 3 V, VHISENSE - VOUTLO = 100 mV                                       |     | 65  |      | dB   |

NOTE 3. This parameter is ensured by design and is not production tested.

# inhibit

| PARAMETER       | TEST CONDITIONS | MIN  | TYP | MAX  | UNIT |
|-----------------|-----------------|------|-----|------|------|
| Start threshold |                 | 1.85 | 2.1 | 2.35 | V    |
| Hysteresis      |                 | 0.08 | 0.1 | 0.14 | V    |
| Stop threshold  |                 | 1.76 |     |      | V    |

# overvoltage protection

| PARAMETER                  | TEST CONDITIONS | MIN | TYP | MAX | UNIT              |
|----------------------------|-----------------|-----|-----|-----|-------------------|
| Overvoltage trip threshold |                 | 112 | 115 | 120 | %V <sub>REF</sub> |
| Hysteresis                 | See Note 3      | 10  |     | mV  |                   |

NOTE 3: This parameter is ensured by design and is not production tested.

# overcurrent protection

| PARAMETER          | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--------------------|-----------------|-----|-----|-----|------|
| OCP trip threshold |                 | 80  | 100 | 125 | mV   |
| Input bias current |                 |     |     | 100 | nA   |



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electrical characteristics over recommended operating virtual junction temperature range,  $V_{CC} = 5 \text{ V}$  (unless otherwise noted) (continued)

# deadtime

|        | PARAMETER                | TEST CONDITIONS | MIN  | TYP | MAX  | UNIT |
|--------|--------------------------|-----------------|------|-----|------|------|
| LOUID  | High-level input voltage |                 | 2.4  |     |      | V    |
| LOHIB  | Low-level input voltage  |                 |      |     | 1.33 | V    |
| LOWIDD | High-level input voltage | See Note 3      | 2.38 |     |      | V    |
| LOWDR  | Low-level input voltage  | See Note 3      |      |     | 1.23 | V    |

NOTE 3: This parameter is ensured by design and is not production tested.

# **LODRV**

|       | PARAMETER                | TEST CONDITIONS | MIN  | TYP | MAX  | UNIT |
|-------|--------------------------|-----------------|------|-----|------|------|
| LODRV | High-level input voltage |                 | 1.70 |     |      | V    |
| LODKV | Low-level input voltage  |                 |      |     | 0.95 | V    |

# input undervoltage lockout

| PARAMETER       | TEST CONDITIONS | MIN | TYP  | MAX  | UNIT |
|-----------------|-----------------|-----|------|------|------|
| Start threshold |                 | 3.8 | 4.08 | 4.46 | V    |
| Hysteresis      |                 | 0.4 | 0.5  | 0.6  | V    |
| Stop threshold  |                 | 3.3 |      |      | V    |



# **TPS56100** HIGH-EFFICIENCY DSP POWER SUPPLY CONTROLLER FOR 5-V INPUT SYSTEMS SLVS201A – JUNE 1999 – REVISED JULY 1999

# electrical characteristics over recommended operating virtual junction temperature range, V<sub>CC</sub> = 5 V (unless otherwise noted) (continued)

# output drivers

| PARAMETER               |                  | TEST CONDITIONS                                                                     | MIN | TYP | MAX | UNIT |
|-------------------------|------------------|-------------------------------------------------------------------------------------|-----|-----|-----|------|
|                         | High-side sink   | Duty cycle < 2%, $t_{pW}$ < 100 $\mu$ s, $V_{BOOT} - V_{BOOTLO} = 4.5 \text{ V}$ ,  | 0.7 |     |     |      |
| Peak output             | High-side source | VHIGHDR = 0.5 V (source) or 4 V (sink),<br>See Note 3                               | 1.2 |     |     | A    |
| current<br>(see Note 4) | Low-side sink    | Duty Cycle < 2%, $t_{pW}$ < 100 $\mu$ s, $T_J = 125^{\circ}C$ , $V_{DRV} = 4.5 V$ , | 1.3 |     |     | A    |
|                         | Low-side source  | VLOWDR = 0.5 V (source) or 4 V (sink),<br>See Note 3                                | 1.4 |     |     |      |
|                         | High-side sink   | $T_J = 125$ °C, $V_{BOOT} - V_{BOOTLO} = 4.5 V$                                     |     |     | 5   |      |
| Output resistance       | High-side source | V <sub>HIGHDR</sub> = 4 V (source) or 0.5 V (sink)                                  |     |     | 75  | Ω    |
| (see Note 4)            | Low-side sink    | $T_J = 125^{\circ}C$ , $V_{DRV} = 4.5 V$ ,                                          |     |     | 9   | 22   |
| (222 232 )              | Low-side source  | V <sub>LOWDR</sub> = 4 V (source) or 0.5 V (sink)                                   |     |     | 75  |      |

NOTES: 3. This parameter is ensured by design and is not production tested.

4. The pullup/pulldown circuits of the drivers are bipolar and MOSFET transistors in parallel. The peak output current rating is the combined current from the bipolar and MOSFET transistors. The output resistance is the R<sub>ds(on)</sub> of the MOSFET transistor when the voltage on the driver output is less than the saturation voltage of the bipolar transistor.

# supply current

| PARAMETER TEST CONDITIONS |                                                                                                         | TEST CONDITIONS                                                                                                                                                                                                                                                                                                              | MIN | TYP | MAX | UNIT |
|---------------------------|---------------------------------------------------------------------------------------------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----|-----|-----|------|
| VCC                       | Supply voltage range                                                                                    |                                                                                                                                                                                                                                                                                                                              | 4.5 | 5   | 5.5 | V    |
|                           |                                                                                                         | $V_{INHIBIT} = 5 \text{ V},$ $V_{P} \text{ code} \neq 11111,$ $V_{CC} > 4.46 \text{ V}$ at startup, $V_{BOOTLO} = 0 \text{ V}$                                                                                                                                                                                               |     | 3   | 10  |      |
| VCC Quiescent current     |                                                                                                         | $ \begin{array}{lll} \mbox{VINHIBIT} = 5 \mbox{ V,} & \mbox{VP code} \neq \mbox{11111,} \\ \mbox{V}_{CC} > 4.46 \mbox{ V at startup,} & \mbox{V}_{BOOTLO} = 0 \mbox{ V,} \\ \mbox{C}_{HIGHDR} = 50 \mbox{ pF,} & \mbox{C}_{LOWDR} = 50 \mbox{ pF,} \\ \mbox{f}_{SWX} = 200 \mbox{ kHz,} & \mbox{See Note 3} \\ \end{array} $ |     | 5   |     | mA   |
|                           | High-side driver VINHIBIT = 0 V or VP code = 11111 or V <sub>CC</sub> < 3.8 V at startup, VBOOTLO = 0 V |                                                                                                                                                                                                                                                                                                                              |     |     | 90  | μА   |
|                           | quiescent<br>current                                                                                    | $ \begin{array}{lll} \mbox{VINHIBIT} = 5 \mbox{ V,} & \mbox{VP code} \neq \mbox{11111, V}_{CC} > 4.46 \mbox{ V at startup,} \\ \mbox{VBOOT} = 13 \mbox{ V,} & \mbox{VBOOTLO} = 0 \mbox{ V,} \\ \mbox{CHIGHDR} = 50 \mbox{ pF,} & \mbox{f}_{SWX} = 200 \mbox{ kHz (see Note 3)} \\ \end{array} $                              |     | 2   |     | mA   |

NOTE 3: This parameter is ensured by design and is not production tested.



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# switching characteristics over recommended operating virtual-junction temperature range, $V_{CC} = 5 \text{ V}$ (unless otherwise noted)

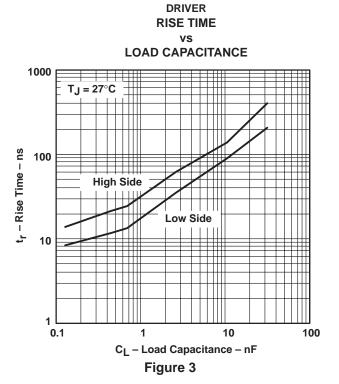
| PARAMETER                                  |                                                 | TEST CONDITIONS                                                                           | MIN | TYP | MAX  | UNIT |
|--------------------------------------------|-------------------------------------------------|-------------------------------------------------------------------------------------------|-----|-----|------|------|
|                                            | VSENSE to HIGHDR or LOWDR (excluding dead-time) | 1.3 V $\leq$ V <sub>VREF</sub> $\leq$ 2.6 V, 10 mV overdrive (see Note 3)                 |     | 230 | 300  | ns   |
| Propagation delay                          | OCP comparator                                  |                                                                                           |     | 1   |      |      |
| , ,                                        | OVP comparator                                  | See Note 3                                                                                |     | 1   |      | μs   |
|                                            | PWRGD comparator                                |                                                                                           |     | 1   |      |      |
|                                            | SLOWST comparator                               | Overdrive = 10 mV (see Note 3)                                                            |     | 700 | 1000 | ns   |
| Rise and fall time                         | HIGHDR output                                   | $C_L = 6 \text{ nF},$ $V_{BOOTLO} = 4.5 \text{ V},$ $V_{J} = 125^{\circ}\text{C}$         |     |     | 120  | ns   |
| Rise and fall time                         | LOWDR output                                    | $C_L = 6 \text{ nF},$ $V_{DRV} = 4.5 \text{ V},$ $T_J = 125^{\circ}\text{C}$              |     |     | 80   | 115  |
| Deglitch time (Includes OCP                |                                                 |                                                                                           | 2   |     | 5    |      |
| comparator propagation delay)              | OVP                                             | See Note 3                                                                                |     |     | 5    | μs   |
| Decrease for                               | Historida MDO accesion                          | VHISENSE = 4.5 V, VIOUTLO pulsed from 4.5 V to 4.4 V, 100 ns rise/fall times (see Note 3) |     |     | 3    |      |
| Response time                              | High-side VDS sensing                           | VHISENSE = 3 V, VIOUTLO pulsed from 3 V to 2.9 V, 100 ns rise/fall times (see Note 3)     |     |     | 3    | μs   |
| Short-circuit protection rising-edge delay | SCP                                             | LOSENSE = 0 V (see Note 3)                                                                |     |     | 500  | ns   |
| Turnon/turnoff delay                       | V <sub>DS</sub> sensing sample/hold switch      | 3 V ≤ VHISENSE ≤ 5.5 V,<br>VLOSENSE = VHISENSE (see Note 3)                               |     |     | 100  | ns   |
| Crossover delay time                       | LOWDR to HIGHDRV, and LOHIB to LOWDR            | See Note 3                                                                                |     |     | 200  | ns   |
| Prefilter pole frequency                   | Hysteretic comparator                           | See Note 3                                                                                |     | 5   |      | MHz  |
| Propagation delay                          | LODRV                                           | See Note 3                                                                                |     |     | 400  | ns   |

NOTE 3: This parameter is ensured by design and is not production tested.

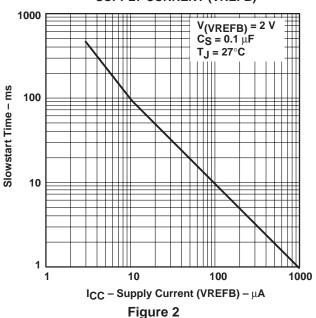


# SLOWSTART CAPACITANCE 100 V(VREFB) = 2 V I(VREFB) = 100 μA T J = 27°C 10 0.01 0.001 0.0010 0.0100 0.1000 1 Slowstart Capacitance – μF

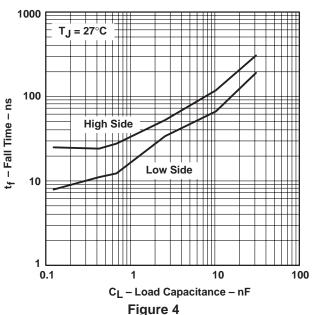
Figure 1

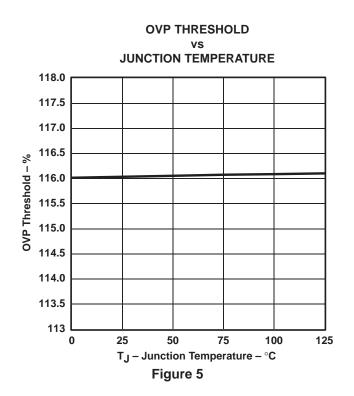


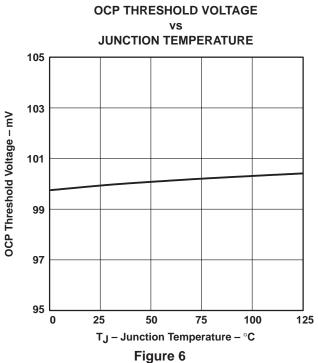
SLOWSTART TIME
vs
SUPPLY CURRENT (VREFB)



DRIVER
FALL TIME
vs
LOAD CAPACITANCE





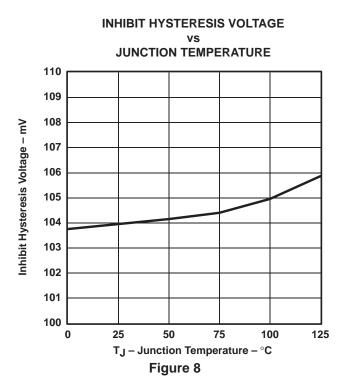


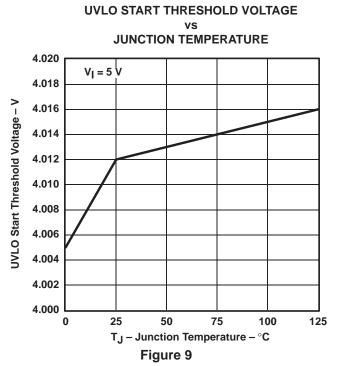
# 2.10 2.05 2.05 2.00 25 50 75 100 125

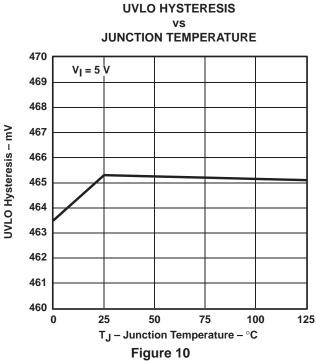
T<sub>J</sub> – Junction Temperature – °C

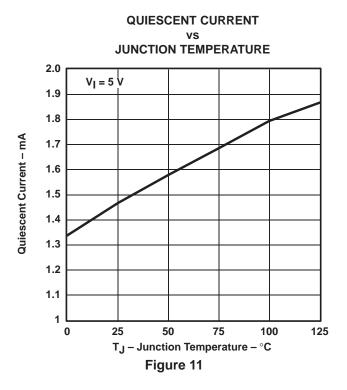
Figure 7

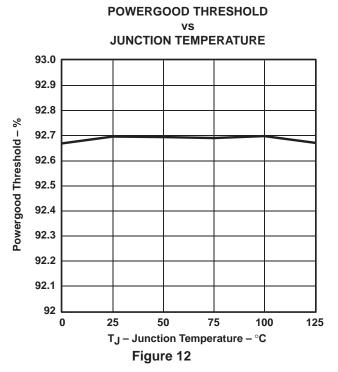
**INHIBIT START THRESHOLD VOLTAGE** 



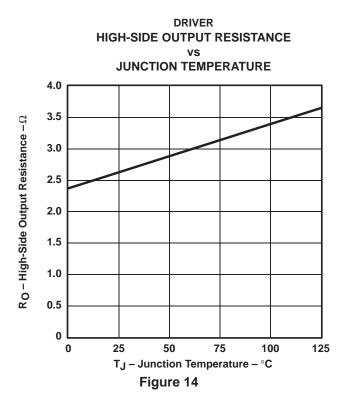






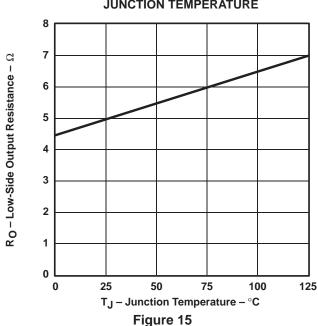


# **SLOW START CHARGE CURRENT JUNCTION TEMPERATURE** 15 V<sub>(VREFB)</sub> = 1.3 V $R(VREFB) = 20 k\Omega$ Slow Start Charge Current - µA 14 13 12 11 10 50 75 0 25 100 125 T<sub>J</sub> - Junction Temperature - °C

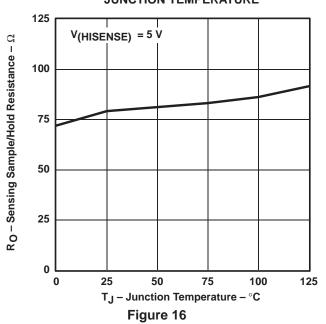


DRIVER
LOW-SIDE OUTPUT RESISTANCE
vs
JUNCTION TEMPERATURE

Figure 13



# SENSING SAMPLE/HOLD RESISTANCE vs JUNCTION TEMPERATURE





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# APPLICATION INFORMATION

The hysteretic-type controller method used in the TPS56100 controller gives very fast transient response for today's high-speed DSP applications. Traditional PWM-type controllers use an oscillator to control the timing of the control signals used to adjust the output voltage. During a transient load event, the PWM-type controller must wait until the next oscillator cycle to begin the output voltage adjustment process. This delay causes output droop (or overshoot) and longer recovery times. Hysteretic-type controllers, such as the TPS56100, are self-oscillating and require no cycle-time to begin the recovery process. Hysteretic controllers have extremely high gain and are sensitive to noise. The TPS56100 has internal low-pass noise filters to eliminate much of this problem, however an external RC low-pass filter between the output and VSENSE input is recommended.

The TPS56100 controller includes all of the functions necessary for a dependable high-efficiency power converter. High-current synchronous MOSFET drivers are used for fast, low-loss switching allowing for efficiencies greater than 90%. An internal bootstrap circuit provides the high-side drive voltage necessary for the upper n-channel MOSFET. Overcurrent protection protects the power supply in case of load faults. Overvoltage protection protects the load in case of high-side switch failure. Programmable hysteresis allows users to tailor the output ripple and operating frequency to suit their needs. Slowstart provides a controlled rampup time for the output voltage eliminating output overshoot. Inhibit is provided for sequencing of the converter in multiple-voltage circuits. Power good provides an indication that the output voltage is within operating limits. The design of each of these functions is discussed in detail in the following. Refer to Figure 19 for location of components discussed in the following.



### APPLICATION INFORMATION

# frequency calculation

A detailed derivation of frequency calculation is shown in the application report, *Designing Fast Response Synchronous Buck Regulators Using the TPS5210*, TI Literature number SLVA044. When less accurate results are acceptable, the simplified equation shown below can be used:

$$f_{S} \cong \frac{\left(V_{O} \times \left[V_{I} - V_{O}\right] \times ESR\right)}{\left(V_{I} \times L \times Hysteresis \ Window\right)}$$

# control section

Below are the equations needed to select the various components within the control section. Component reference numbers refer to the example application given at the end of this section. Details and the derivations of the equations used in this section are available in the application report *Designing Fast Response Synchronous Buck Regulators Using the TPS5210*, TI Literature number SLVA044.

# output voltage selection

Of course the most important function of the power supply is to regulate the output voltage to a specific value. Values between 1.3 V and 2.6 V can be easily set by shorting the correct VP inputs to ground. Values above the maximum reference voltage (2.6 V) can be set by changing the reference voltage to any convenient voltage within its range and selecting values for R2 and R3 to give the correct output. Select R3:

R3 << than  $V_{REF}/I_{BIAS(VSENSE)}$ ; a recommended value is 10 k $\Omega$ 

Then, calculate R2 using:

$$V_{O} = V_{REF} \left(1 + \frac{R2}{R3}\right) \text{ or } R2 = \frac{R3 \times \left(V_{O} - V_{REF}\right)}{V_{REF}}$$

R2 and R3 can also be used to make small adjusts to the output voltage within the reference-voltage range. If there is no need to adjust the output voltage, R3 can be eliminated. R2, R3 (if used), and C7 are used as a noise filter; calculate using:

$$C7 = \frac{150 \text{ ns}}{(R2 \parallel R3)}$$

Recommended values for 3.3 V:  $V_{REF}$  = 1.65 V, R3 = 1.00 k $\Omega$ , R2 = 1.00 k $\Omega$ , and C7 = 100 pF.

# slowstart timing

Slowstart reduces the start-up stresses on the power-stage components and reduces the input current surge. Slowstart timing is a function of the reference-voltage current (determined by R5) and is independent of the reference voltage. The first step in setting slowstart timing will be to determine R5:

R5 should be between 7 k $\Omega$  and 300 k $\Omega$ , a recommended value is 20 k $\Omega$ .



# APPLICATION INFORMATION

# slowstart timing (continued)

Set the slowstart timing using the formula:

$$C5 = \frac{t_{SS}}{\left(5 \times R_{VREFB}\right)} \cong \frac{t_{SS}}{(5 \times R5)}$$

Where

C5 = Slowstart capacitance in  $\mu$ F

 $t_{SS}$  = Slowstart timing in  $\mu s$ 

R<sub>VRFFB</sub> = Resistance from VREFB to GND in ohms (≈ R5)

# hysteresis voltage

A hysteretic controller regulates by self-oscillation, thus requiring a small ripple voltage on the output which the input comparator uses for sensing. Once selected, the TPS56100 hysteresis is proportional to the reference voltage; programming Vref to a new value automatically adjusts the hysteresis to be the same percentage of Vref. The actual output ripple voltage is the combination of the hysteresis voltage, overshoot caused by internal delays, and the output capacitor characteristics. Figure 19 shows the hysteresis window voltage ( $V_{HI}$  to  $V_{LO}$ ) and the output voltage ripple ( $V_{MAX}$  to  $V_{MIN}$ ). Since the output current from VREFB should be less than 500  $\mu$ A, the total divider resistance (R4 + R5) should be greater than 7 k $\Omega$ . The hysteresis voltage should be no greater than 60 mV so R5 will dominate the divider.

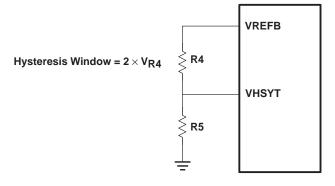


Figure 17. Hysteresis Divider Circuit

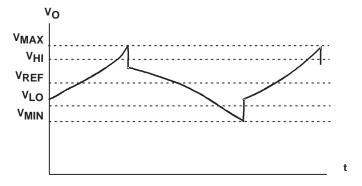


Figure 18. Output Ripple

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### APPLICATION INFORMATION

# hysteresis voltage (continued)

The upper divider resistor, R4, is calculated using:

R4 = 
$$\frac{\text{Hysteresis Window}}{2 \times (\text{VREFB - Hysteresis Window})} \times \text{R5} \cong \frac{\text{V}_{\text{HYST}}(\%)}{(2 \times 100)} \times \text{R5}$$

Where

Hysteresis Window = the desired peak-to-peak hysteresis voltage.

VREFB = selected reference voltage.

# current limit

Current limit can be implemented using the on-resistance of the upper FETs as the sensing element. Select R7:

R7 
$$\ll \frac{V_{OCP}}{I_{Bias(OCP)}} \le \frac{0.1 \text{ V}}{(100 \times 100 \text{ nA})} \le 10 \text{ k}\Omega$$
 (A recommended value is 1 k $\Omega$ )

The IOUT signal is used to drive the current limit divider. The voltage at IOUT at the output current trip point will be:

$$V_{IOUT(Trip)} = \frac{\left(2 \times R_{DS(ON)} \times TF\right)}{NumFETs} \times I_{O(Trip)}$$

Where

NumFETS = Number of upper FETS in Parallel.

 $TF = R_{DS(ON)}$  temperature correction factor.

 $I_{O(Trip)}$  = Desired output current trip level (A).

Calculate R6 using:

$$R6 = \left(\frac{V_{IOUT(Trip)}}{0.1 V} - 1\right) \times R7$$

Note that since  $R_{DS(ON)}$  of MOSFETs can vary from lot to lot and with temperature, tight current-limit control (less than 1.5 x  $I_O$ ) using this method is not practical. If tight control is required, an external current-sense resistor in series with the drain of the upper FET can be used with HISENSE and LOSENSE connected across the resistor.



# **APPLICATION INFORMATION**

# application example

Below is a typical application schematic. The circuit can be divided into the power-stage section and the control-circuit section. The power stage must be tailored to the input/output requirements of the application. The control circuit is basically the same for all applications with some minor tweaking of specific values.

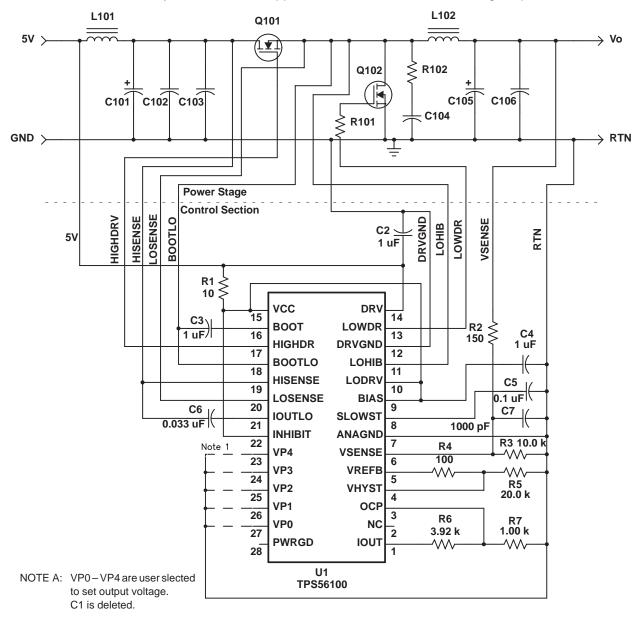


Figure 19. Typical Application Schematic



# **APPLICATION INFORMATION**

# application example (continued)

**Table 2. Power Stage Components** 

| Ref Des      | Function                                | 4–A Out                                                          | 8–A Out                                                          | 12-A Out                                                         | 20-A Out                                                             |
|--------------|-----------------------------------------|------------------------------------------------------------------|------------------------------------------------------------------|------------------------------------------------------------------|----------------------------------------------------------------------|
| C101         | Input Bulk<br>Capacitor                 | Sanyo,<br>10TPB220M,<br>220–μF, 10–V, 20%                        | Sanyo,<br>10SA220M,<br>2 x 220–μF, 10–V, 20%                     | Sanyo,<br>10SP470M,<br>2 x 470–μF, 10–V, 20%                     | Sanyo,<br>10SP470M,<br>3 x 470–μF, 10–V, 20%                         |
| C102         | Input Mid-Freq<br>Capacitor             | muRata,<br>GRM42–6Y5V105Z025A,<br>1.0–μF, 25–V,<br>+80%–20%, Y5V | muRata,<br>GRM42–6Y5V225Z016A,<br>2.2–μF, 16–V,<br>+80%–20%, Y5V | muRata,<br>GRM42–6Y5V225Z016A,<br>2.2–μF, 16–V, +80%–20%,<br>Y5V | muRata,<br>GRM42–6Y5V105Z025A,<br>3 x 1.0–μF, 25–V,<br>+80%–20%, Y5V |
| C103         | Input Hi–Freq<br>Bypass<br>Capacitor    | muRata,<br>GRM39X7R104K016A,<br>0.1–μF, 16–V, X7R                | muRata,<br>GRM39X7R104K016A,<br>0.1–μF, 16–V, X7R                | muRata,<br>GRM39X7R104K016A,<br>2 x 0.1–μF, 16–V, X7R            | muRata,<br>GRM39X7R104K016A,<br>3 x 0.1–µF, 16–V, X7R                |
| C104         | Snubber<br>Capacitor                    | muRata,<br>GRM39X7R102K050A,<br>1000–pF, 50–V, X7R               | muRata,<br>GRM39X7R102K050A,<br>1000–pF, 50–V, X7R               | muRata,<br>GRM39X7R102K050A,<br>2 x 1000 pF, 50-V, X7R           | muRata,<br>GRM39X7R102K050A,<br>3 x 1000–pF, 50–V, X7R               |
| C105         | Output Bulk<br>Capacitor                | Sanyo,<br>4TPC150,<br>2 x 150–μF, 4–V, 20%                       | Sanyo,<br>4SP820M,<br>820–μF, 4–V, 20%                           | Sanyo,<br>4SP820M,<br>2 x 820–μF, 4–V, 20%                       | Sanyo,<br>4SP820M,<br>3 x 820–μF, 4–V, 20%                           |
| C106         | Output Hi-Freq<br>Bypass Capaci-<br>tor | muRata,<br>GRM39X7R104K016A,<br>0.1–μF, 16–V, X7R                | muRata,<br>GRM39X7R104K016A,<br>0.1–μF, 16–V, X7R                | muRata,<br>GRM39X7R104K016A,<br>2 x 0.1–μF, 16–V, X7R            | muRata,<br>GRM39X7R104K016A,<br>3 x 0.1–µF, 16–V, X7R                |
| L101         | Input Filter<br>Inductor                | CoilCraft,<br>DO1608C-332,<br>3.3-µH, 2.0-A                      | Coiltronics,<br>UP2B–2R2,<br>2.2–μH, 7.2–A                       | Coiltronics,<br>UP2B–2R2,<br>2.2–µH, 7.2–A                       | Coiltronics,<br>UP3B-1R0,<br>1-µH, 12.5-A                            |
| L102         | Output Filter<br>Inductor               | CoilCraft,<br>DO3316P–332,<br>3.3–μΗ, 6.1–A                      | Coiltronics,<br>UP3B–2R2,<br>2.2–µH, 9.2–A                       | Coiltronics,<br>UP4B–1R5,<br>1.5–μΗ, 13.4–A                      | MicroMetals,<br>T68–8/90 Core w/7T #16,<br>1.0–μH, 25–A              |
| R101         | Lo–Side Gate<br>Resistor                | 3.3–Ω, 1/16–W, 5%                                                | 3.3–Ω, 1/16–W, 5%                                                | 2 x 3.3–Ω, 1/16–W, 5%                                            | 3 x 3.3–Ω, 1/16–W, 5%                                                |
| R102         | Snubber<br>Resistor                     | 2.7–Ω, 1/10–W, 5%                                                | 2.7–Ω, 1/10–W, 5%                                                | 2 x 2.7–Ω, 1/10–W, 5%                                            | 3 x 2.7–Ω, 1/10–W, 5%                                                |
| Q101         | Power Switch                            | IR, IRF7811,<br>NMOS, 11–mΩ                                      | IR, IRF7811,<br>NMOS, 11–mΩ                                      | IR, 2 x IRF7811, NMOS,<br>11-mΩ                                  | IR, 2 x IRF7811, NMOS,<br>11–mΩ                                      |
| Q102         | Synchronous<br>Switch                   | IR, IRF7811,<br>NMOS, 11-mΩ                                      | IR, IRF7811,<br>NMOS, 11-mΩ                                      | IR, 2 x IRF7811, NMOS,<br>11–mΩ                                  | IR, 3 x IRF7811, NMOS,<br>11–mΩ                                      |
| Nominal Fre  | equency <sup>†</sup>                    | 280 kHz                                                          | 250 kHz                                                          | 170 kHz                                                          | 170 kHz                                                              |
| Hysteresis \ | Nindow                                  | 15 mV                                                            | 15 mV                                                            | 15 mV                                                            | 15 mV                                                                |

<sup>†</sup>Nominal frequency measured with Vo set to 1.5 V.

The values listed above are recommendations based on actual test circuits. Many variations of the above are possible based upon the desires and/or requirements of the user. Performance of the circuit is equally, if not more, dependent upon the layout than on the specific components, as long as the device parameters are not exceeded. Fast-response, low-noise circuits require critical attention to the layout details. Even though the operating frequencies of typical power supplies are relatively low compared to today's microprocessor circuits, the power levels and edge rates can cause severe problems both in the supply and the load. The power stage, having the highest current levels and greatest dv/dt rates, should be given the greatest attention.



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# APPLICATION INFORMATION

# layout guidelines

Good power supply results will only occur when care is given to proper design and layout. Layout will affect noise pickup and generation and can cause a good design to perform with less than expected results. With a range of currents from milliamps to tens or even hundreds of amps, good power supply layout is much more difficult than most general PCB designs. The general design should proceed from the switching node to the output, then back to the driver section and, finally, place the low-level components. Below are several specific points to consider *before* layout of a TPS56100 design begins.

- 1. All sensitive analog components should be referenced to ANAGND. These include components connected to SLOWST, IOUT, OCP, VSENSE, VREFB, VHYST, BIAS, and LOHIB.
- Analog ground and drive ground should be isolated as much as possible. Ideally, analog ground will connect
  to the ground side of the bulk storage capacitors on V<sub>O</sub>, and drive ground will connect to the main ground
  plane close to the source of the low-side FET.
- 3. Connections from the drivers to the gate of the power FETs should be as short and wide as possible to reduce stray inductance. This becomes more critical if external gate resistors are not being used.
- 4. The bypass capacitor for the DRV input should be placed close to the TPS56100 and be connected to DRVGND.
- 5. The bypass capacitor for  $V_{CC}$  should be placed close to the TPS56100 and be connected to AGND.
- 6. When configuring the high-side driver as a floating driver, the connection from BOOTLO to the power FETs should be as short and as wide as possible. The other pins that also connect to the power FETs, LOHIB and LOSENSE, should have a separate connection to the FETS since BOOTLO will have large peak currents flowing through it.
- 7. When configuring the high-side driver as a floating driver, the bootstrap capacitor (connected from BOOT to BOOTLO) should be placed close to the TPS56100.
- 8. When configuring the high-side driver as a ground-referenced driver, BOOTLO should be connected to DRVGND.
- 9. The bulk storage capacitors across V<sub>I</sub> should be placed close to the power FETS. High-frequency bypass capacitors should be placed in parallel with the bulk capacitors and connected close to the drain of the high-side FET and to the source of the low-side FET.
- 10. High-frequency bypass capacitors should be placed across the bulk storage capacitors on  $V_{O}$ .
- 11. HISENSE and LOSENSE should be connected very close to the drain and source, respectively, of the high-side FET. HISENSE and LOSENSE should be routed very close to each other to minimize differential-mode noise coupling to these traces. Ceramic decoupling capacitors should be placed close to where HISENSE connects to Vin, to reduce high-frequency noise coupling on HISENSE.



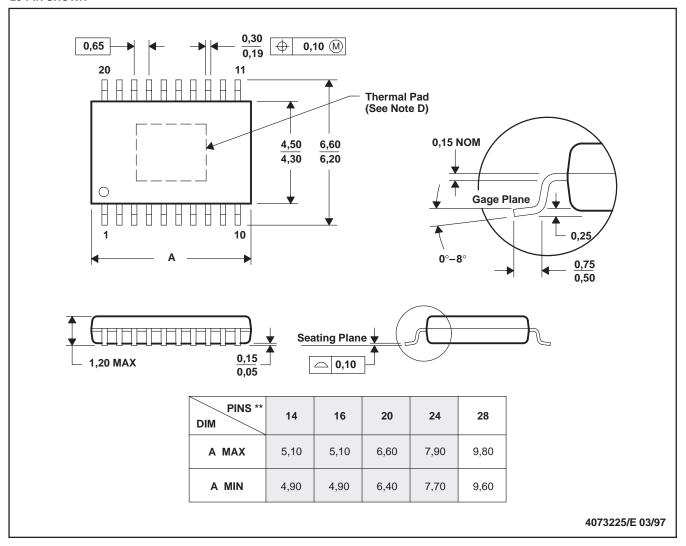
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# **MECHANICAL DATA**

# PWP (R-PDSO-G\*\*)

# PowerPAD™ PLASTIC SMALL-OUTLINE PACKAGE

# **20-PIN SHOWN**



NOTES: B. All linear dimensions are in millimeters.

C. This drawing is subject to change without notice.

D. Body dimensions do not include mold flash or protrusions.

E. The package thermal performance may be enhanced by bonding the thermal pad to an external thermal plane. This pad is electrically and thermally connected to the backside of the die and possibly selected leads.

F. Falls within JEDEC MO-153

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